Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/644,153	FUKUWAKI, TAKEHIRO
Examiner	Art Unit

2871

Richard H. Kim

SEARCHED				
Class	Subclass	Date	Examiner	
349	58	6/7/2005	RHK	
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
						
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East Search	6/7/2005	RHK		
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